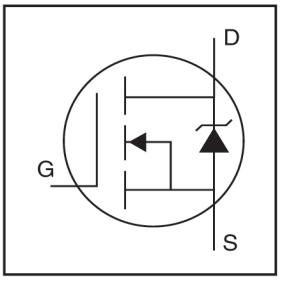
PD - 95387

International
IOR Rectifier

IRLL014PbF

HEXFET® Power MOSFET

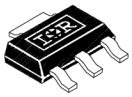
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Logic-Level Gate Drive
- R_{DS}(on) Specified at V_{GS}=4V & 5V
- Fast Switching
- Ease of Paralleling
- Lead-Free



V_{DSS} = 60V

$R_{DS(on)}$ = 0.20Ω

I_D = 2.7A



SOT-223

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOT-223 package is designed for surface-mount using vapor phase, infra red, or wave soldering techniques. Its unique package design allows for easy automatic pick-and-place as with other SOT or SOIC packages but has the added advantage of improved thermal performance due to an enlarged tab for heatsinking. Power dissipation of grreater than 1.25W is possible in a typical surface mount application.

Absolute Maximum Ratings

	Parameter	Max.	Units
I_D @ Tc = 25°C	Continuous Drain Current, V_{GS} @ 10 V	2.7	A
I_D @ Tc = 100°C	Continuous Drain Current, V_{GS} @ 10 V	1.7	
I_{DM}	Pulsed Drain Current ①	22	
P_D @Tc = 25°C	Power Dissipation	3.1	W
P_D @T_A = 25°C	Power Dissipation (PCB Mount)**	2.0	
	Linear Derating Factor	0.025	W/°C
	Linear Derating Factor (PCB Mount)**	0.017	
V_{GS}	Gate-to-Source Voltage	-/+10	V
E_{AS}	Single Pulse Avalanche Energy②	100	mJ
I_{AR}	Avalanche Current①	2.7	A
E_{AR}	Repetitive Avalanche Energy①	0.31	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.5	V/ns
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	°C
	Soldewring Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-PCB	—	40	°C/W
$R_{\theta JA}$	Junction-to-Ambient. (PCB Mount)**	—	60	

** When mounted on 1" SQUARE pcb (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60	—	—	V	V_{GS} = 0V, I_D = 250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.073	—	V/°C	Reference to 25°C, I_D = 1mA
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.20	Ω	V_{GS} = 5.0V, I_D = 1.6A ④
		—	—	0.28		V_{GS} = 4.0V, I_D = 1.4A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0	—	2.0	V	V_{DS} = V_{GS}, I_D = 250µA
g_{fs}	Forward Transconductance	3.2	—	—	S	V_{DS} = 25V, I_D = 1.6 A
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	µA	V_{DS} = 60V, V_{GS} = 0V
		—	—	250		V_{DS} = 48V, V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	V_{GS} = 10V
	Gate-to-Source Reverse Leakage	—	—	-100		V_{GS} = -10V
Q_g	Total Gate Charge	—	—	8.4	nC	I_D = 10A
Q_{gs}	Gate-to-Source Charge	—	—	3.5		V_{DS} = 48V
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	6.0		V_{GS} = 5.0V, See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	9.3	—	ns	V_{DD} = 30V
t_r	Rise Time	—	110	—		I_D = 10A
$t_{d(off)}$	Turn-Off Delay Time	—	17	—		R_G = 12 Ω
t_f	Fall Time	—	26	—		R_D = 2.8 Ω, See Fig. 10 ④
L_D	Internal Drain Inductance	—	4.0	—	nH	Between lead, 6mm(0.25in) from package and center of die contact.
L_S	Internal Source Inductance	—	6.0	—		
C_{iss}	Input Capacitance	—	400	—	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	—	170	—		V_{DS} = 25V
C_{rss}	Reverse Transfer Capacitance	—	42	—		f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	---	---	2.7	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	---	---	22		
V_{SD}	Diode Forward Voltage	—	—	1.6	V	T_J = 25°C, I_S = 2.7A, V_{GS} = 0V ④
t_{rr}	Reverse Recovery Time	—	65	130	ns	T_J = 25°C, I_F = 10A
Q_{rr}	Reverse RecoveryCharge	—	0.33	0.65	µC	di/dt = 100A/µs ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

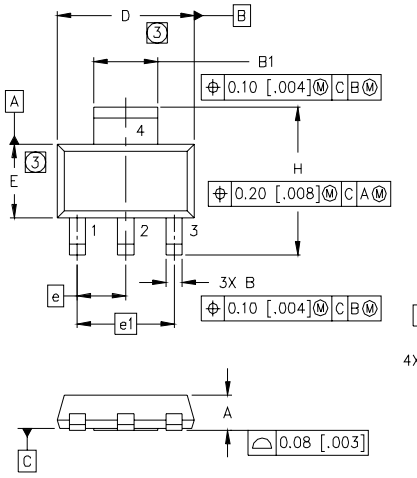
② V_{DD}=25V, starting T_J = 25°C, L =16 mH R_G = 25Ω, I_{AS} = 2.7A. (See Figure 12)

③ I_{SD} ≤ 10A, di/dt ≤ 90A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 150°C

④ Pulse width ≤ 300µs; duty cycle ≤ 2%.

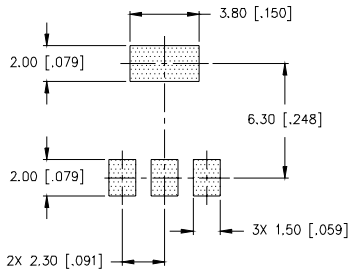
SOT-223 (TO-261AA) Package Outline

Dimensions are shown in milimeters (inches)



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	1.55	1.80	.061	.071
B	0.65	0.85	.026	.033
B1	2.95	3.15	.116	.124
C	0.25	0.35	.010	.014
D	6.30	6.70	.248	.264
E	3.30	3.70	.130	.146
e	2.30 BSC		.0905 BSC	
e1	4.60 BSC		.181 BSC	
H	6.71	7.29	.264	.287
L	0.91	—	.036	—
L1	0.061 BSC		.0024 BSC	
θ	—	10°	—	10°

MINIMUM RECOMMENDED FOOTPRINT



LEAD ASSIGNMENTS

1 = GATE
2 = DRAIN
3 = SOURCE
4 = DRAIN

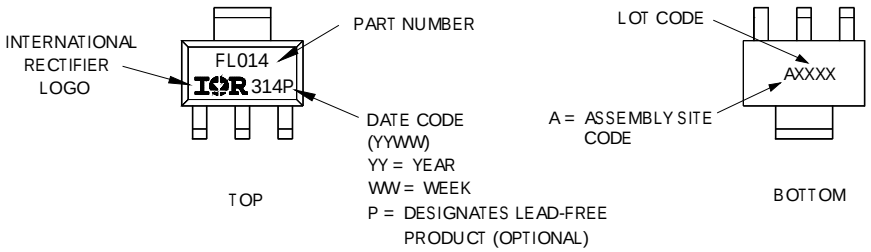
NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS DO NOT INCLUDE MOLD FLASH.
4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-261AA.
5. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

SOT-223 (TO-261AA) Part Marking Information

HEXFET PRODUCT MARKING

EXAMPLE: THIS IS AN IRFL014



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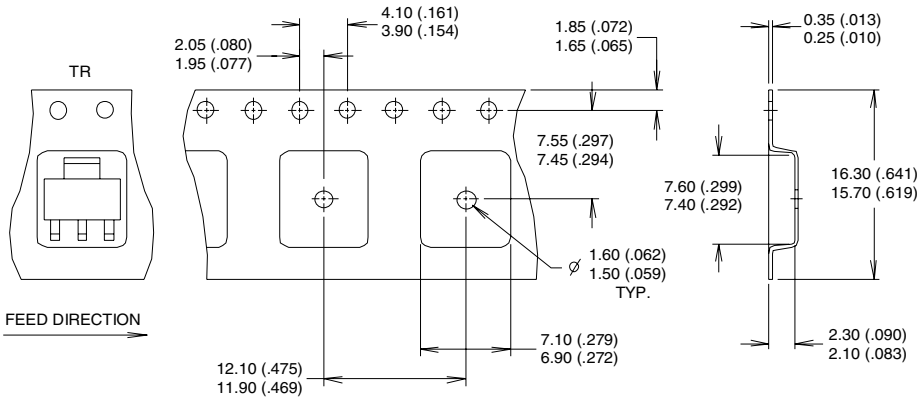
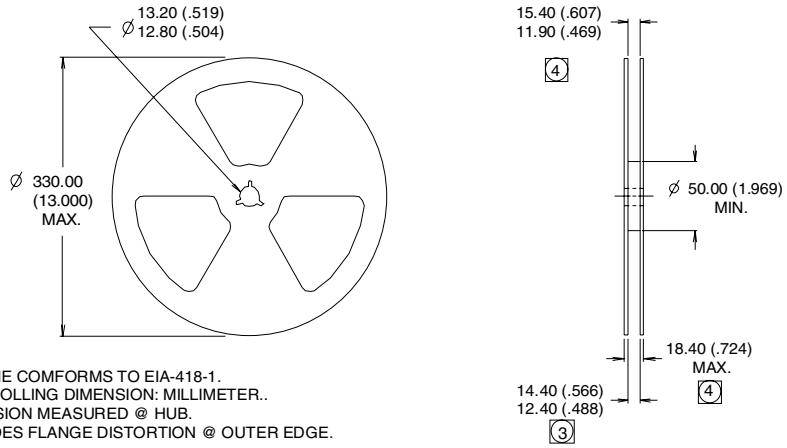
SOT-223 (TO-261AA) Tape & Reel Information

Dimensions are shown in milimeters (inches)



NOTES :
1. CONTROLLING DIMENSION: MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.
3. EACH Ø330.00 (13.00) REEL CONTAINS 2,500 DEVICES.



NOTES :
1. OUTLINE COMFORMS TO EIA-418-1.
2. CONTROLLING DIMENSION: MILLIMETER..
3. DIMENSION MEASURED @ HUB.
4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.

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